Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/781,769	HON ET AL.	
Examiner	Art Unit	
David Nhu	2818	

	SEAR	CHED	
Class	Subclass	Date	Examiner
438	4 55	6/8/2005	DN
	30, 33	1	1
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INTERFERENCE SEARCHED			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
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